Master Program in Data Science and Business Informatics Statistics for Data Science Lesson 15 - Graphical summaries

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Condensed observations



- Probability models governs some random phenomena
- Confronted with a new phenomenon, we want to learn about the randomness associated with it
 - Parametric (efficient) vs non-parameteric (general) methods
- Record observations x₁,..., x_n (a dataset)
- *n* can be large: need to condense for easy visual comprehension
- Graphical summaries:
 - Univariate: histograms, kernel density estimates, empirical distribution functions
 - Multi-variate: scatter plots

The empirical CDF

- Record observations x₁,..., x_n (a dataset)
- Empirical cumulative distribution function (CDF):

$$F_n(x) = \frac{|\{i \in [1, n] \mid x_i \leq x\}|}{n}$$

• Empirical complementary cumulative distribution function (CCDF):

$$\bar{F}_n(x) = 1 - F_n(x)$$

- A r.v. X is completely characterized by its CDF F_X
- Estimating F_X through F_n allow for estimating other quantities by plugging F_n in the place of F_X , e.g., E[X] as

$$E[X] = \sum_{a} a \cdot P(X = a) = \sum_{a} a \cdot \frac{|\{i \mid x_i = a\}|}{n} = \frac{1}{n} \sum_{i} x_i$$

• What about p.m.f. and d.f.?

Barplots

- For discrete data, barplots provide frequency counts for values
 - approximate the p.m.f. due to the law of large numbers



• For continuous data, frequency counting of distinct values do not work. Why?

Histograms

- Histograms provide frequency counts for ranges of values:
 - Split the support to intervals, called *bins*:

$$B_1,\ldots,B_m$$

where the length $|B_i|$ is called the *bin width*

• Count observations in each bin and normalize them:

$$A_i = \frac{|\{j \in [1, n] \mid x_j \in B_i\}|}{n} \approx P(X \in B_i)$$

Plot bars whose area is proportional to A_i

$$A_i = |B_i| \cdot H_i$$
 $H_i = \frac{|\{j \in [1, n] \mid x_j \in B_i\}|}{n|B_i|}$

Choice of the bin width

• Bins of equal width:

$$B_i = (r + (i-1)b, r+ib]$$
 for $i \in [1, m]$

where $r \leq \min p$ oint and b is the bin width



Fig. 15.2. Histograms of the Old Faithful data with different bin widths.

• Mean Integrated Square Error (MISE), for $\hat{f}()$ density estimation of f():

$$MISE = E[\int (\hat{f}(u) - f(u))^2 du] = \int \int (\hat{f}(u) - f(u))^2 (f(x))^n du dx$$

• Scott's normal reference rule (minimize MISE for Normal density):

$$b = 3.49 \cdot s \cdot n^{-1/3}$$
, where $s = \hat{\sigma} = \sqrt{\frac{1}{n-1} \sum_{i=1}^{n} (x_i - \bar{x})^2}$ is the sample standard deviation

Choice of the bin width

- $b = 2 \cdot IQR \cdot n^{-1/3}$, where $IQR = Q_3 Q_1$
 - It replaces $3.49 \cdot s$ in the Scott's rule by $2 \cdot IQR$ (more robust to outlier)
 - Q_3 is 75% percentile of x_1, \ldots, x_n
 - Q_1 is 25% percentile of x_1, \ldots, x_n
- Variable bin width
 - Logarithmic binning in power laws
- Alternative: number of bins given equal bin width b:
 - $m = \left\lceil \frac{\max x_i \min x_i}{b} \right\rceil$

•
$$m = \lceil \sqrt{n} \rceil$$

•
$$m = \lceil \log_2 n \rceil + 1$$

- Sturges's formula:
 - \square assume *m* bins: $0, 1, \ldots, m-1$
 - $\hfill\square$ assume normal distribution of true density
 - \square approximate normal density as Bin(n, 0.5), hence absolute frequency of i^{th} bin is $\binom{m-1}{i}$

□ total frequency is $n = \sum_{i=0}^{m-1} \binom{m-1}{i} = 2^{m-1}$, hence $m = \lceil \log_2 n \rceil + 1$

N.B. R's hist method take bin width as a suggestion, then it rounds bins differently See R script

[Freedman–Diaconis' choice]

[Sturges' formula]

Density estimation

- Problem with histograms: as *m* increases, histogram becomes unusable
- Idea: estimate density function by putting a pile (of sand) around each observation
- Kernels state the shape of the pile
 - Epanechnikov $\frac{3}{4}(1-u^2)$ for $-1 \le u \le 1$
 - Triweight $rac{35}{32}(1-u^2)^3$ for $-1\leq u\leq 1$

▶ Normal
$$\frac{1}{\sqrt{2\pi}}e^{-\frac{1}{2}u^2}$$
 for $-\infty < u < \infty$



Kernel density estimation (KDE)

A Kernel is a function $K : \mathbb{R} \to \mathbb{R}$ such that

- K is a probability density, i.e., $K(u) \ge 0$ and $\int_{-\infty}^{\infty} K(u) du = 1$
- K is symmetric, i.e., K(-u) = K(u)
- [sometime, it is required that] K(u) = 0 for |u| > 1
- A bandwidth h is a scaling factor over the support of K (from [-1,1] to [-h,h])

• if
$$X \sim K$$
, then $\frac{X}{h} \sim \frac{1}{h}K(\frac{u}{h})$ [Change-of-Unit rule]



Kernel density estimation (KDE)



Let x_1, \ldots, x_n be the observations

• *K* scaled and shifted at x_i is $\frac{1}{h}K(\frac{u-x_i}{h})$, with support $[x_i - h, x_i + h]$ The kernel density estimate is defined as:

$$f_{n,h}(u) = \frac{1}{nh} \sum_{i=1}^{n} K(\frac{u-x_i}{h})$$

• It is a probability density!

See R script

[Prove it]

KDE vs histograms



• KDE has less variability!

Choice of the bandwidth

- Note. The choice of the kernel is not critical: different kernels give similar results
- A problem. The choice of the bandwith h is critical (and it may depend on the kernel)
- Mean Integrated Squared Error (MISE) is

$$E[\int_{-\infty}^{\infty} (f_{n,h}(u) - f(u))^2 du] = \int \int_{-\infty}^{\infty} (f_{n,h,x}(u) - f(u))^2 (f(x))^n du dx$$

where f(x) is the true density function and observations are independent

• For f(x) being the Normal density, the MISE is minimized for

$$h = (rac{4}{3})^{rac{1}{5}} \cdot s \cdot n^{-rac{1}{5}}$$
 [Normal reference method]

Kernel density estimation (KDE)

- A problem. The choice of the bandwith h is critical (and it may depend on the kernel)
- Automatic selection of h
 - Plug-in selectors (iterative bandwith selection)
 - Cross-validation selectors (part of data for estimation and part for evaluation)
- Another problem. When the support is finite, symmetric kernels give meaningless results
- Boundary kernels
 - Kernel (truncation) and renormalization
 - Linear (combination) kernel
 - Beta boundary kernels
 - Reflective kernels (density=0 at boundaries)
- See [Scott, 2015] for a complete book on KDE

David W. Scott (2015)

Multivariate density estimation: Theory, practice, and visualization.

John Wiley & Sons, Inc.